


<b>Search Notes</b> 	<b>Application/Control No.</b> 10692516	<b>Applicant(s)/Patent Under Reexamination</b> YEOW ET AL.
	<b>Examiner</b> VANEL FRENEL	<b>Art Unit</b> 3687

SEARCHED			
Class	Subclass	Date	Examiner
705	28	4/12/08	V.F
705	10	4/12/08	V.F

SEARCH NOTES		
Search Notes	Date	Examiner
Updated West 2.0 SEARCH	12/15/08	V.F
Updated search performed	8/25/09	V.F
Updated search performed	3/26/10	V.F

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
705	28, 10	3/26/10	V.F

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